

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT
(IECEE) CB SCHEME

CB TEST CERTIFICATE

Product

Time of Flight (ToF) sensor

Name and address of the applicant

STMicroelectronics (R&D) LTD.
1 Tanfield, 1st floor,
EH3 5DA Edinburgh, United Kingdom

Name and address of the manufacturer

Shenzhen STS Microelectronics Co. Ltd
16, Tao Hua Road Futian Free Trade Zone,
518048 Shenzhen, China

Name and address of the factory

Shenzhen STS Microelectronics Co. Ltd
16, Tao Hua Road Futian Free Trade Zone,
518048 Shenzhen, China

Note: When more than one factory, please report on page 2

☐ Additional Information on page 2

Ratings and principal characteristics

LASER CLASS 1;
Power supply: -0,5 V to +3,47 V;
Operating temperature: -30°C to +85°C

Trademark / Brand (if any)



Customer's Testing Facility (CTF) Stage used

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Model / Type Ref.

VL53L8

Additional information (if necessary may also be reported on page 2)

Only hazards resulting from laser radiation have been addressed.
See test report for information about National and/or Group Differences.☐ Additional Information on page 2

A sample of the product was tested and found to be in conformity with

IEC 60825-1:2014

As shown in the Test Report Ref. No. which forms part of this Certificate

LE-L117/23

This CB Test Certificate is issued by the National Certification Body

Österreichischer Verband für Elektrotechnik
OVE Certification
Kahlenberger Str. 2A, 1190 Wien, Austria

Date: 2023-09-01

Digitally signed by T. Neumayer
Email=t.neumayer@ove.at
Signature: Dipl.-Ing. T. Neumayer